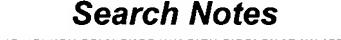


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/534,453	CLARK ET AL.
Examiner	Art Unit	
Richard L. Chiesa	1724	

**SEARCHED**

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner